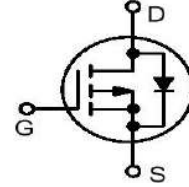




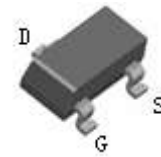
### FEATURES

- Super High Dense Cell Design for Extremely LOW  $R_{DS(ON)}$
- Reliable and Rugged
- Electrostatic Sensitive Devices.



### APPLICATIONS

- Power Management in Notebook.
- Portable Equipment.
- Battery Powered System.



**SOT-23**

### ORDERING INFORMATION

Type No.	Marking	Package Code
2311	2311	SOT-23

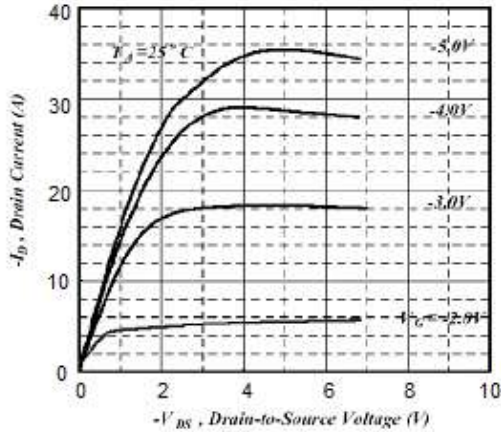
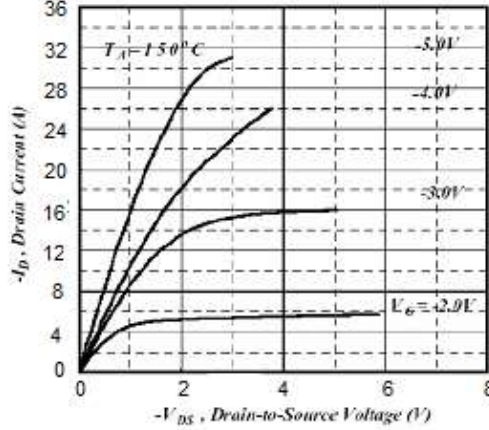
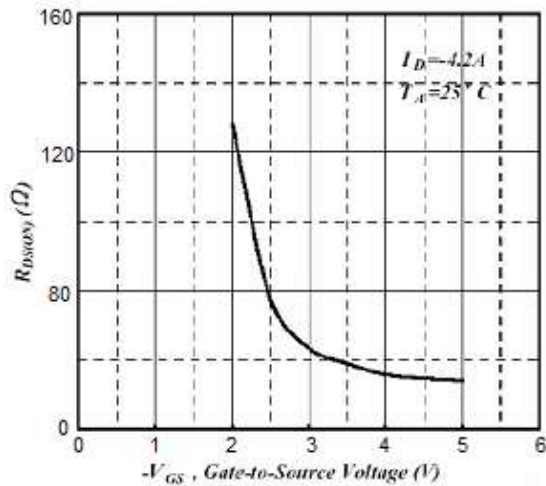
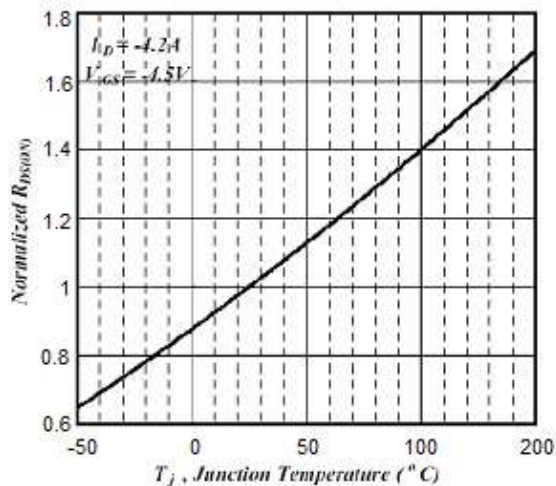
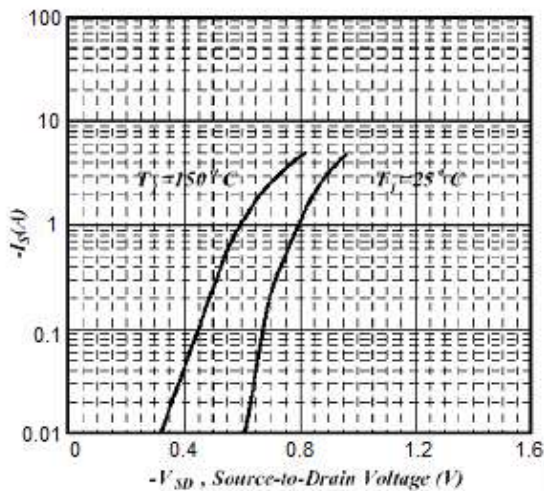
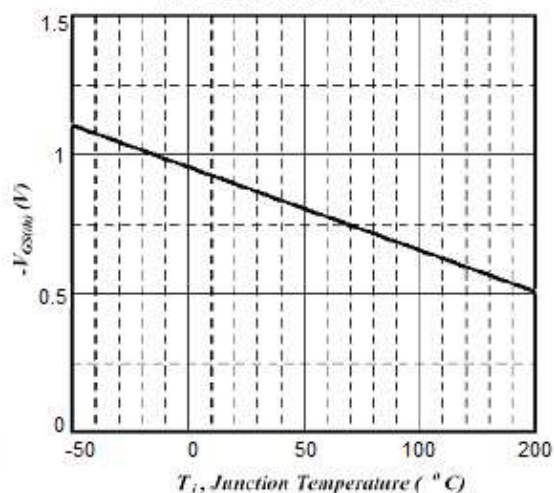
### MAXIMUM RATING @ $T_a=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Units
$V_{DSS}$	Drain-Source voltage	-20	V
$V_{GSS}$	Gate -Source voltage	$\pm 8$	V
$I_D$	Maximum Drain current	$T_A=25^\circ\text{C}$ $T_A=70^\circ\text{C}$	A
$I_{DM}$	Pulsed Drain current	-30	A
$P_D$	Power Dissipation	1.37	W
$R_{\theta JA}$	Thermal resistance, Junction-to-Ambient	90	$^\circ\text{C/W}$
$T_J, T_{stg}$	Operating Junction and Storage Temperature Range	-55~+150	$^\circ\text{C}$



### ELECTRICAL CHARACTERISTICS @ Ta=25°C unless otherwise specified

Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=-250\mu A$	-20	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=-250\mu A$	-0.5	-0.75	-1.2	V
Forward Transconductance	gfs	$V_{DS}=-5V, I_D=-2.8A$	-	9	-	S
Gate-body Leakage	$I_{GSS}$	$V_{DS}=0V, V_{GS}=8V$	-	-	100	nA
		$V_{DS}=0V, V_{GS}=-8V$	-	-	-100	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=-12V, V_{GS}=0V$	-	-	-1	$\mu A$
On state drain current	$I_{D(ON)}$	$V_{DS}=-5V, V_{GS}=-4.5V$	-30	-	-	A
Drain-Source on-resistance	$R_{DS(ON)}$	$V_{GS}=-10V, I_D=-4.5A$	-	-	53	m $\Omega$
		$V_{GS}=-4.5V, I_D=-4.2A$	-	-	65	
		$V_{GS}=-2.5V, I_D=-2.0A$	-	-	100	
		$V_{GS}=-1.8V, I_D=-1.0A$	-	-	250	
Diode forward voltage	$V_{SD}$	$V_{GS}=0V, I_S=-1.2A$	-	-	-1.2	V
Maximum Body-Diode Continuous Current	$I_S$				-2	A
Total Gate Charge	Qg	$V_{DS}=-16V, V_{GS}=-4.5V, I_D=-4.2A$	-	10.6	-	nC
Gate-Source Charge	Qgs		-	2.32	-	
Gate-Drain Charge	Qgd		-	3.68	-	
Input capacitance	$C_{ISS}$	$V_{DS}=-15V, V_{GS}=0V, f=1.0MHz$	-	740	-	pF
Output capacitance	$C_{OSS}$		-	167	-	
Reverse transfer capacitance	$C_{RSS}$		-	126	-	
Turn-On Delay Time	$t_{D(ON)}$	$V_{DS} = -15V, I_D = -4.2A, R_G = 6\Omega, V_{GS} = -10V, R_D = 3.6\Omega$	-	5.9	-	ns
Rise Time	$t_R$		-	3.6	-	
Turn-Off Delay Time	$t_{D(OFF)}$		-	32.4	-	
Fall Time	$t_F$		-	2.6	-	
Reverse Recovery Time	Trr	$I_S=-4.2A, V_{GS}=0$	-	27.7	-	ns
Reverse Recovery Charge	Qrr	$dI/dt=100A/\mu s$	-	22	-	nC


**TYPICAL CHARACTERISTICS @ Ta=25°C unless otherwise specified**

**Fig 1. Typical Output Characteristics**

**Fig 2. Typical Output Characteristics**

**Fig 3. On-Resistance v.s. Gate Voltage**

**Fig 4. Normalized On-Resistance v.s. Junction Temperature**

**Fig 5. Forward Characteristic of Reverse Diode**

**Fig 6. Gate Threshold Voltage v.s. Junction Temperature**



P-Channel Enhancement Mode Power Mosfet

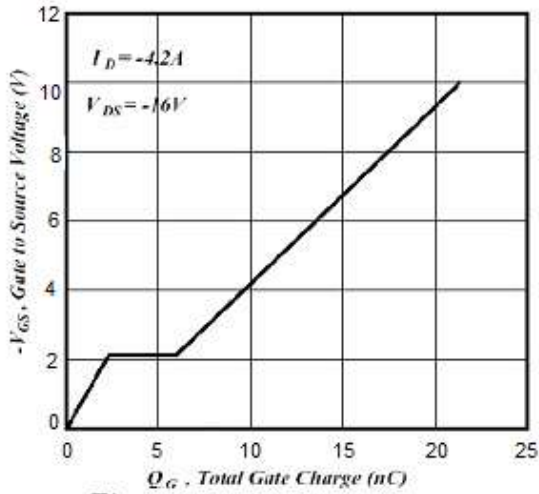


Fig 7. Gate Charge Characteristics

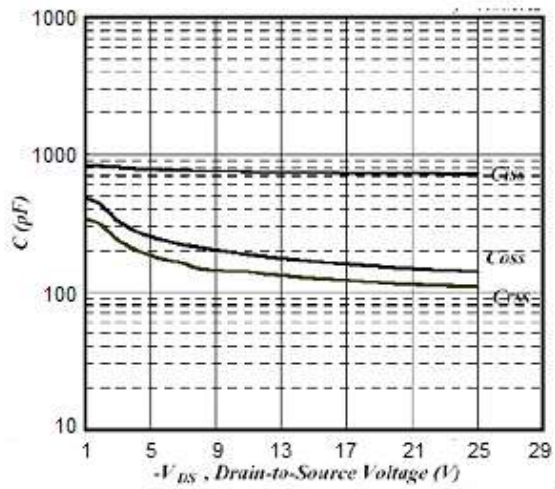


Fig 8. Typical Capacitance Characteristics

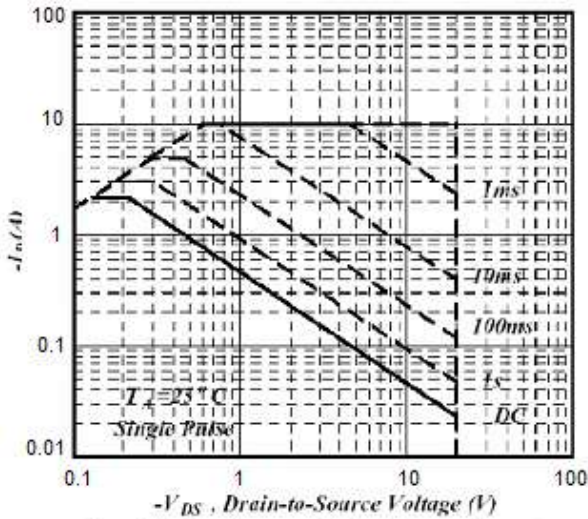


Fig 9. Maximum Safe Operating Area

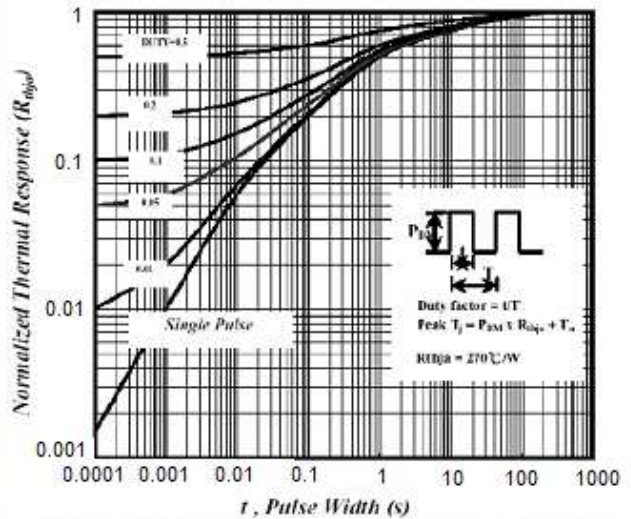


Fig 10. Effective Transient Thermal Impedance

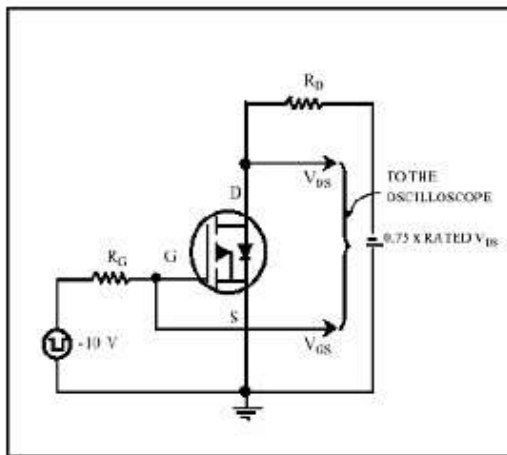


Fig 11. Switching Time Circuit

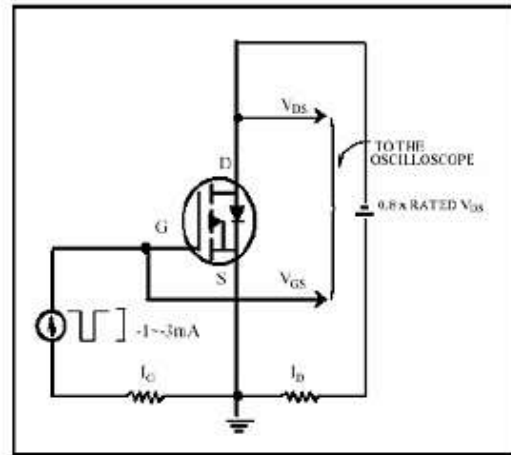


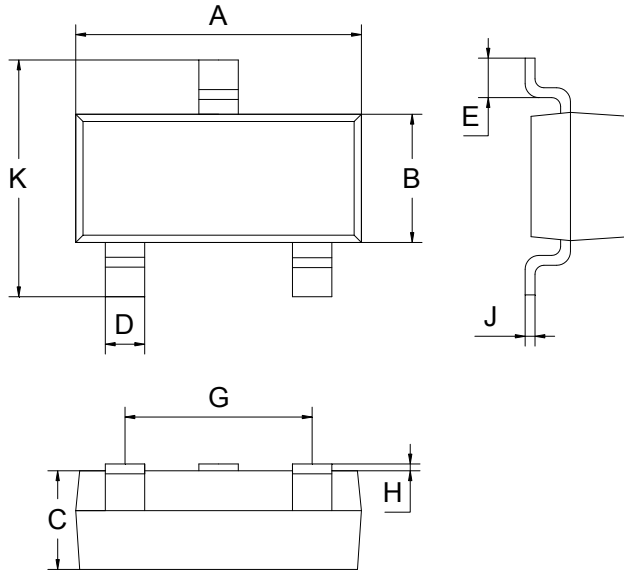
Fig 12. Gate Charge Circuit



### PACKAGE OUTLINE

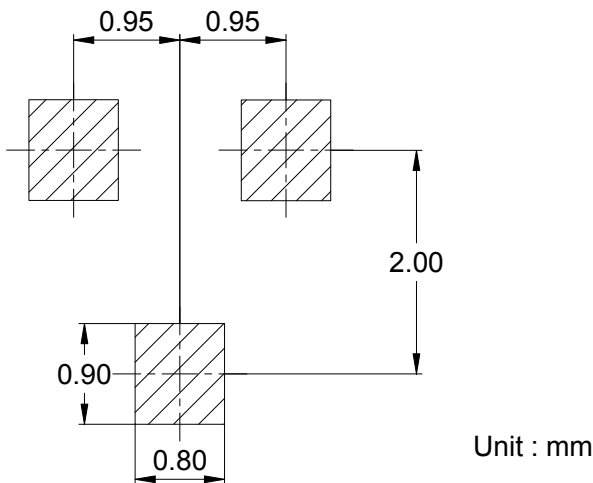
Plastic surface mounted package

SOT-23



SOT-23		
Dim	Min	Max
A	2.70	3.10
B	1.10	1.50
C	0.9	1.1
D	0.3	0.5
E	0.35	0.48
G	1.80	2.00
H	0.02	0.1
J	0.05	0.15
K	2.20	2.60
All Dimensions in mm		

### SOLDERING FOOTPRINT



Unit : mm

### PACKAGE INFORMATION

Device	Package	Shipping
2311	SOT-23	3000/Tape&Reel